



RF Power LDMOS Transistor

N-Channel Enhancement-Mode Lateral MOSFET

This 89 W asymmetrical Doherty RF power LDMOS transistor is designed for cellular base station applications requiring very wide instantaneous bandwidth capability covering the frequency range of 1805 to 1880 MHz.

1800 MHz

- Typical Doherty Single-Carrier W-CDMA Performance: $V_{DD} = 30$ Vdc, $I_{DQA} = 800$ mA, $V_{GSB} = 0.9$ Vdc, $P_{out} = 89$ W Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

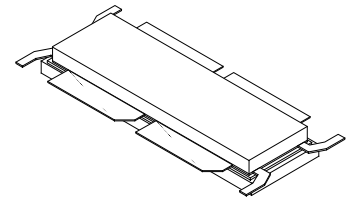
| Frequency | G_{ps} (dB) | η_D (%) | Output PAR (dB) | ACPR (dBc) |
|-----------|---------------|--------------|-----------------|------------|
| 1805 MHz | 16.6 | 47.1 | 7.9 | -31.4 |
| 1840 MHz | 16.7 | 47.5 | 8.0 | -32.9 |
| 1880 MHz | 16.5 | 47.7 | 7.9 | -38.8 |

Features

- Advanced High Performance In-Package Doherty
- Designed for Wide Instantaneous Bandwidth Applications
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Able to Withstand Extremely High Output VSWR and Broadband Operating Conditions
- Designed for Digital Predistortion Error Correction Systems

A2T18H450W19SR6

**1805–1880 MHz, 89 W AVG., 30 V
 AIRFAST RF POWER LDMOS
 TRANSISTOR**



NI-1230S-4S4S

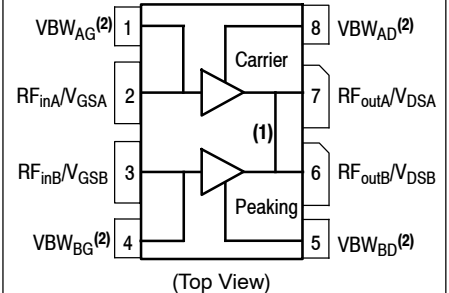


Figure 1. Pin Connections

1. Pin connections 6 and 7 are DC coupled and RF independent.
2. Device cannot operate with the V_{DD} current supplied through pins 1, 4, 5, and 8.

Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|--|-----------|-------------|------|
| Drain-Source Voltage | V_{DSS} | -0.5, +65 | Vdc |
| Gate-Source Voltage | V_{GS} | -6.0, +10 | Vdc |
| Operating Voltage | V_{DD} | 32, +0 | Vdc |
| Storage Temperature Range | T_{stg} | -65 to +150 | °C |
| Case Operating Temperature Range | T_C | -40 to +125 | °C |
| Operating Junction Temperature Range (1,2) | T_J | -40 to +225 | °C |

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value (2,3) | Unit |
|--|-----------------|-------------|------|
| Thermal Resistance, Junction to Case Case Temperature 73°C, 89 W Avg., W-CDMA, 30 Vdc, $I_{DQA} = 800$ mA, $V_{GSB} = 0.9$ Vdc, 1840 MHz | $R_{\theta JC}$ | 0.27 | °C/W |

Table 3. ESD Protection Characteristics

| Test Methodology | Class |
|---------------------------------------|-------|
| Human Body Model (per JESD22-A114) | 2 |
| Machine Model (per EIA/JESD22-A115) | B |
| Charge Device Model (per JESD22-C101) | IV |

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

Off Characteristics

| | | | | | |
|---|-----------|---|---|----|-----------------|
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 65$ Vdc, $V_{GS} = 0$ Vdc) | I_{DSS} | — | — | 10 | μAdc |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 32$ Vdc, $V_{GS} = 0$ Vdc) | I_{DSS} | — | — | 5 | μAdc |
| Gate-Source Leakage Current (4) ($V_{GS} = 5$ Vdc, $V_{DS} = 0$ Vdc) | I_{GSS} | — | — | 1 | μAdc |

On Characteristics - Side A, Carrier

| | | | | | |
|--|--------------|------|------|-----|-----|
| Gate Threshold Voltage ($V_{DS} = 10$ Vdc, $I_D = 200$ μAdc) | $V_{GS(th)}$ | 0.8 | 1.2 | 1.6 | Vdc |
| Gate Quiescent Voltage ($V_{DD} = 30$ Vdc, $I_{DA} = 800$ mAdc, Measured in Functional Test) | $V_{GSA(Q)}$ | 1.6 | 1.8 | 1.9 | Vdc |
| Drain-Source On-Voltage ($V_{GS} = 10$ Vdc, $I_D = 2.0$ Adc) | $V_{DS(on)}$ | 0.05 | 0.15 | 0.3 | Vdc |

On Characteristics - Side B, Peaking

| | | | | | |
|--|--------------|------|------|-----|-----|
| Gate Threshold Voltage ($V_{DS} = 10$ Vdc, $I_D = 360$ μAdc) | $V_{GS(th)}$ | 0.8 | 1.2 | 1.6 | Vdc |
| Drain-Source On-Voltage ($V_{GS} = 10$ Vdc, $I_D = 3.6$ Adc) | $V_{DS(on)}$ | 0.05 | 0.15 | 0.3 | Vdc |

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.nxp.com/RF/calculators>.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.nxp.com/RF> and search for AN1955.
4. Each side of device measured separately.

(continued)

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|---|----------|------|-------|-------|------|
| Functional Tests - 1805 MHz ^(1,2,3) (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 30\text{ Vdc}$, $I_{DQA} = 800\text{ mA}$, $V_{GSB} = 0.9\text{ Vdc}$, $P_{out} = 89\text{ W Avg.}$, $f = 1805\text{ MHz}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset. | | | | | |
| Power Gain | G_{ps} | 15.5 | 16.6 | 18.5 | dB |
| Drain Efficiency | η_D | 45.0 | 47.1 | — | % |
| Output Peak-to-Average Ratio @ 0.01% Probability on CCDF | PAR | 7.5 | 7.9 | — | dB |
| Adjacent Channel Power Ratio | ACPR | — | -31.4 | -30.0 | dBc |

Functional Tests - 1880 MHz ^(1,2,3) (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 30\text{ Vdc}$, $I_{DQA} = 800\text{ mA}$, $V_{GSB} = 0.9\text{ Vdc}$, $P_{out} = 89\text{ W Avg.}$, $f = 1880\text{ MHz}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.

| | | | | | |
|--|----------|------|-------|-------|-----|
| Power Gain | G_{ps} | 15.5 | 16.5 | 18.5 | dB |
| Drain Efficiency | η_D | 45.0 | 47.7 | — | % |
| Output Peak-to-Average Ratio @ 0.01% Probability on CCDF | PAR | 7.5 | 7.9 | — | dB |
| Adjacent Channel Power Ratio | ACPR | — | -33.8 | -30.0 | dBc |

Load Mismatch ⁽³⁾ (In Freescale Doherty Test Fixture, 50 ohm system) $I_{DQA} = 800\text{ mA}$, $V_{GSB} = 0.9\text{ Vdc}$, $f = 1840\text{ MHz}$, 12 μsec (on), 10% Duty Cycle

| | |
|--|-----------------------|
| VSWR 10:1 at 32 Vdc, 420 W Pulsed CW Output Power (3 dB Input Overdrive from 250 W Pulsed CW Rated Power) | No Device Degradation |
|--|-----------------------|

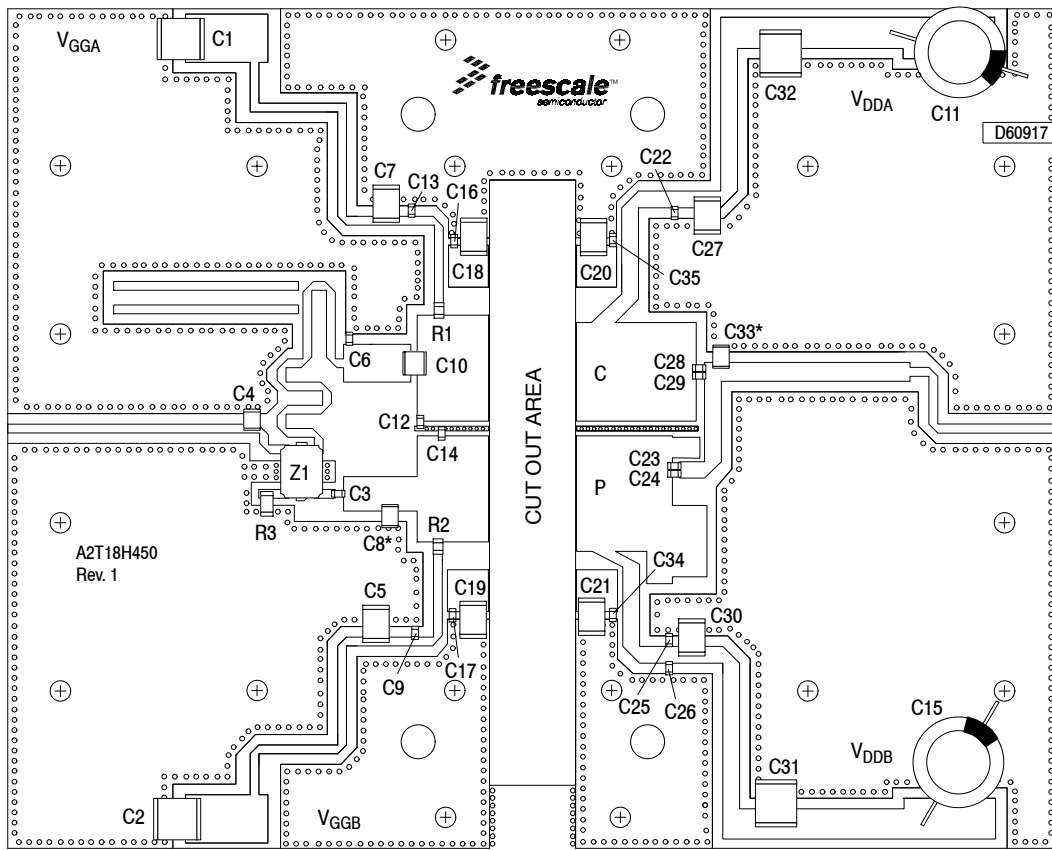
Typical Performance ⁽³⁾ (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 30\text{ Vdc}$, $I_{DQA} = 800\text{ mA}$, $V_{GSB} = 0.9\text{ Vdc}$, 1805–1880 MHz Bandwidth

| | | | | | |
|--|--------------------|---|-------|---|-------|
| P_{out} @ 1 dB Compression Point, CW | P1dB | — | 199 | — | W |
| P_{out} @ 3 dB Compression Point ⁽⁴⁾ | P3dB | — | 550 | — | W |
| AM/PM (Maximum value measured at the P3dB compression point across the 1805–1880 MHz frequency range) | Φ | — | -20 | — | ° |
| VBW Resonance Point (IMD Third Order Intermodulation Inflection Point) | VBW _{res} | — | 140 | — | MHz |
| Gain Flatness in 75 MHz Bandwidth @ $P_{out} = 89\text{ W Avg.}$ | G_F | — | 0.4 | — | dB |
| Gain Variation over Temperature (-30°C to +85°C) | ΔG | — | 0.008 | — | dB/°C |
| Output Power Variation over Temperature (-30°C to +85°C) | $\Delta P1dB$ | — | 0.027 | — | dB/°C |

Table 5. Ordering Information

| Device | Tape and Reel Information | Package |
|-----------------|---|---------------|
| A2T18H450W19SR6 | R6 Suffix = 150 Units, 56 mm Tape Width, 13-inch Reel | NI-1230S-4S4S |

- V_{DDA} and V_{ddb} must be tied together and powered by a single DC power supply.
- Part internally matched both on input and output.
- Measurements made with device in an asymmetrical Doherty configuration.
- $P3dB = P_{avg} + 7.0\text{ dB}$ where P_{avg} is the average output power measured using an unclipped W-CDMA single-carrier input signal where output PAR is compressed to 7.0 dB @ 0.01% probability on CCDF.



*C8 and C33 are mounted vertically.

Note: V_{DDA} and V_{DDB} must be tied together and powered by a single DC power supply.

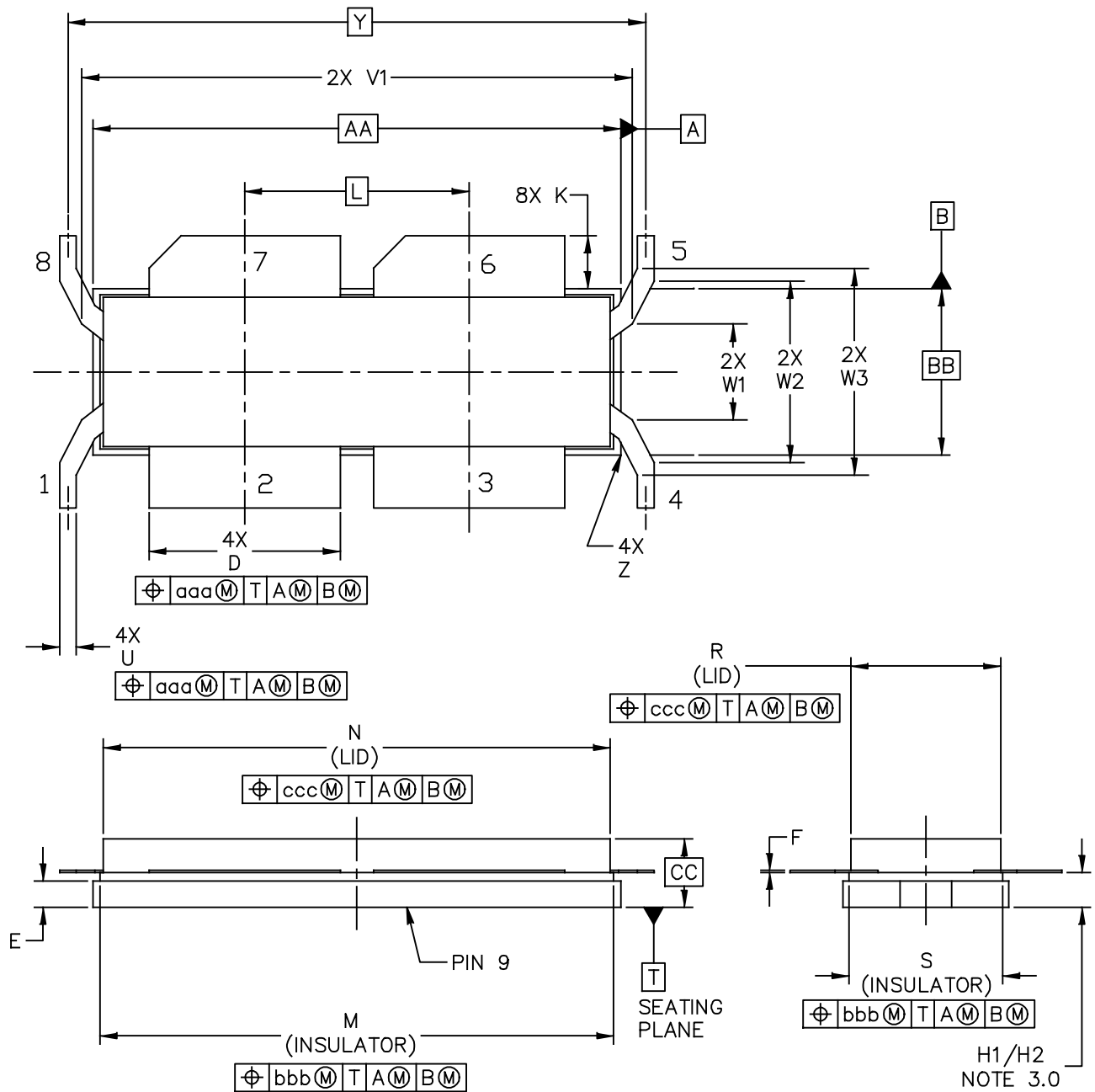
Figure 2. A2T18H450W19SR6 Test Circuit Component Layout

Table 6. A2T18H450W19SR6 Test Circuit Component Designations and Values

| Part | Description | Part Number | Manufacturer |
|--|---|----------------------|--------------|
| C1, C2, C31, C32 | 10 μ F Chip Capacitors | C5750X7R1H106M230KB | TDK |
| C3, C9, C13, C16, C17, C22, C23, C24, C25, C26, C34, C35 | 22 pF Chip Capacitors | ATC600S220JT250XT | ATC |
| C4 | 0.4 pF Chip Capacitor | ATC100B0R4BT500XT | ATC |
| C5, C7, C18, C19, C20, C21, C27, C30 | 4.7 μ F Chip Capacitors | C4532X7R1H475M200KB | TDK |
| C6 | 0.2 pF Chip Capacitor | ATC600S0R2BT250XT | ATC |
| C8 | 1.8 pF Chip Capacitor | ATC100B1R8BT500XT | ATC |
| C10 | 22 pF Chip Capacitor | ATC100B220GT500XT | ATC |
| C11, C15 | 470 μ F, 63 V Electrolytic Capacitors | MCGPR63V477M13X26-RH | Multicomp |
| C12 | 3 pF Chip Capacitor | ATC600S3R0BT250XT | ATC |
| C14 | 2.4 pF Chip Capacitor | ATC600S2R4BT250XT | ATC |
| C28, C29 | 4.7 pF Chip Capacitors | ATC600S4R7CT250XT | ATC |
| C33 | 0.2 pF Chip Capacitor | ATC100B0R2BT500XT | ATC |
| R1 | 4.7 Ω , 1/8 W Chip Resistor | WCR0805-4R7F | Welwyn |
| R2 | 2.2 Ω , 1/8 W Chip Resistor | WCR0805-2R2F | Welwyn |
| R3 | 50 Ω , 10 W Chip Termination | 060120A25X50-2 | Anaren |
| Z1 | 1700–2000 MHz Band, 90°, 5 dB Directional Coupler | X3C19P1-05S | Anaren |
| PCB | Rogers RO4350B, 0.020", $\epsilon_r = 3.66$ | D60917 | MTL |

A2T18H450W19SR6

PACKAGE DIMENSIONS



| | | |
|--|--------------------------|----------------------------|
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| TITLE: NI-1230S-4S4S | DOCUMENT NO: 98ASA00155D | REV: D |
| | STANDARD: NON-JEDEC | |
| | SOT1795-1 | 31 MAY 2016 |

NOTES:

1.0 INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

2.0 CONTROLLING DIMENSION: INCH

3.0 DIMENSION H1 AND H2 ARE MEASURED .030 (0.762 MM) AWAY FROM FLANGE TO CLEAR EPOXY FLOW OUT PARALLEL TO DATUM B. H1 APPLIES TO PINS 2,3,6,7. H2 APPLIES TO PINS 1,4,5,8.

4.0 -DELETED-

| DIM | INCH | | MILLIMETER | | DIM | INCH | | MILLIMETER | |
|--|----------|-------|--------------------|-------|--------------------------|----------------------------|-------|-------------|-------|
| | MIN | MAX | MIN | MAX | | MIN | MAX | MIN | MAX |
| AA | 1.265 | 1.275 | 32.13 | 32.39 | N | 1.218 | 1.242 | 30.94 | 31.55 |
| BB | .397 | .403 | 10.08 | 10.24 | R | .365 | .375 | 9.27 | 9.53 |
| CC | .150 | .200 | 3.81 | 5.08 | S | .365 | .375 | 9.27 | 9.53 |
| D | .455 | .465 | 11.56 | 11.81 | U | .035 | .045 | 0.89 | 1.14 |
| E | .062 | .066 | 1.57 | 1.68 | V1 | 1.320 | 1.330 | 33.53 | 33.78 |
| F | .004 | .007 | 0.10 | 0.18 | T3 | DELETED | | DELETED | |
| H1 | .082 | .090 | 2.08 | 2.29 | W1 | .225 | .235 | 5.72 | 5.97 |
| H2 | .078 | .094 | 1.98 | 2.39 | W2 | .431 | .441 | 10.95 | 10.20 |
| K | .117 | .137 | 2.97 | 3.48 | W3 | .491 | .501 | 12.47 | 12.73 |
| L | .540 BSC | | 13.72 BSC | | Y | 1.390 BSC | | 35.31 BSC | |
| M | 1.219 | 1.241 | 30.96 | 31.52 | Z | --- | R.040 | --- | R1.02 |
| | | | | | aaa | .005 | | 0.13 | |
| | | | | | bbb | .010 | | 0.25 | |
| | | | | | ccc | .020 | | 0.51 | |
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| | | | | | STANDARD: NON-JEDEC | | | | |
| | | | | | SOT1795-1 | | | 31 MAY 2016 | |

PRODUCT DOCUMENTATION AND TOOLS

Refer to the following resources to aid your design process.

Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Development Tools

- Printed Circuit Boards

To Download Resources Specific to a Given Part Number:

1. Go to <http://www.nxp.com/RF>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date | Description |
|----------|------------|---------------------------------|
| 0 | Sept. 2016 | • Initial release of data sheet |

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